

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10697122	CHANG ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Nguyen, Jennifer T	2629

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	102, 207, 211,87-89,204	6/14/07	JN

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
East search, JPO, PG-PUB,IEEE, inventor names, claim interference	6/14/07	JN

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
349	112-119	6/14/07	JN
359	245,290	6/14/07	JN
438	257	6/14/07	JN